Thursday 4 March: Humidity interaction with electronic systems, components and mechanisms

- 09:30-10:00 Introduction to the seminar and humidity effects on electronics: where do we stand? Rajan Ambat, Center for Electronic Corrosion, DTU
- 10:00-10:30 Humidity robustness of vehicle electronics SIR-tests with superimposed self-heating Lothar Henneken, Automotive Electronics, Robert Bosch, Germany
- 10:30-11:00 Analysis of dendritic corrosion phenomena on differently treated power electronic circuit Victoria Zimmermann, Fraunhofer Institute, Erlangen, Germany
- 11:00-11:20 Coffee Break
- 11:20-11:50 Comparison between mixed flowing gas and flowers of sulphur corrosion testing Laura Frisk, Trelic, Finland
- 11:50-12:20 Humidity and material induced failure mechanisms in low and high voltage electronics Markus Meier, Zestron, Germany
- 12:20-13:20 Lunch Break
- 13:20-13:50 The role of carbonaceous material in conductivity: laboratory test and ambient data Luca Ferrero, University of Milan Biccoca, Italy
- 13:50-14:20 To be announced
- 14:20-14:40 Coffee Break
- 14:40-15:10 Chloride containing Foreign Material in Epoxy Mold Compound Lena Saier and Lutz Muller, Automotive Electronics, Robert Bosch, Germany
- 15:10-15:40 The Forensics of Dendrite Shorting Terry Munson, Foresite, USA
- 15:40-15:50 Thursday summary

Friday 5 March: Humidity effect on electronics: Packaging, modelling humidity effects and testing

- 09:30-10:00 Key takeaways from an extrinsic corrosion mechanism during biased humidity tests in packages Amar Mavinkurve, NXP Semiconductors, Netherlands
- 10:00-10:30 Water uptake evaluation in plastic packages: FEM simulation modeling and data comparison with Electrochemical Impedance Spectroscopy experimental approach Sonia Morin, ST Microelectronics, Italy
- 10:30-11:00 Investigation of key influencing factors at automotive H2S-corrosiontesting Stefan Schoemaker, Quality Manager, Osram, Germany
- 11:00-11:20 Coffee Break
- 11:20-11:50 Derivation of local humidity loads inside of vehicle electronics simulation approach Balazs Toth, Automotive Electronics, Robert Bosch, Germany
- 11:50-12:20 Critical level of water film build up for failure and modelling condensation Helene Conseil Gudla & Alessandro Checchi, Mechanical Engineering, Technical University of Denmark
- 12:20-13:20 Lunch
- 13:20-13:50 Electrochemical modeling of leak current phenomenon on PCBA surface Rajan Ambat & Ioannis Mantis, Mechanical Engineering, Technical University of Denmark
- 13:50-14:20 Advanced Humidity Testing under High Voltage Christian Zorn, University of Bremmen, Germany
- 14:20-14:40 Coffee Break
- 14:40-15:10 Climate data analysis for humidity effects on electronics Max Peter Spooner & Murat Kulahci, DTU Compute, Technical University of Denmark
- 15:10-15:40 Why the IEC 60529 water protection standard must be changed? Michael Pecht, CALCE, University of Maryland
- 15:40-15:50 Summary of seminar and concluding remarks